Search Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination	_
10/782,660	LAI ET AL.	
Examiner	Art Unit	
Thinh T. Nguyen	2818	

	SEAR	CHED	
Class	Subclass	Date	Examiner
257	666	6/5/2005	TTN
257	668	6/5/2005	TTN
257	670	6/6/2005	TTN
257	668	6/6/2005	TTN

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST	6/5/2005	TTN
EAST	6/5/2006	TTN
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